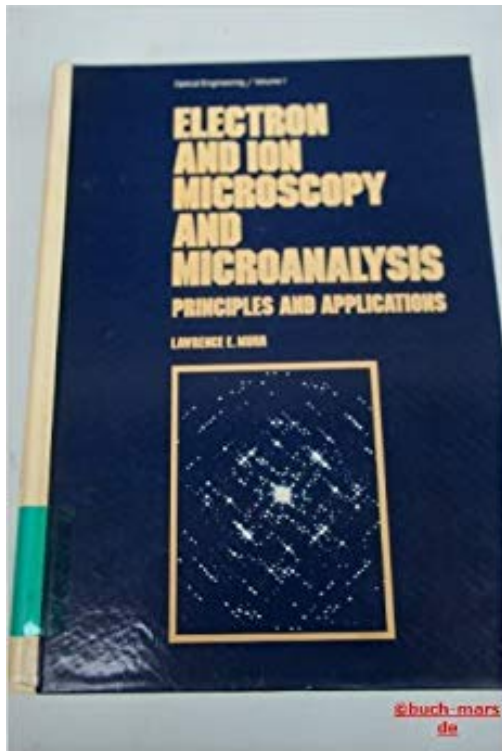


Electron and Ion Microscopy and Microanalysis: Principles and Applications (Optical Engineering) *by* Lawrence E. Murr



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This book is an extension and revision of the author's original book, Electron Optical Applications in Materials Science published in 1970. This book broadens the coverage with a particular aim at developing the analytical concepts underlying the synergism involving both electron and ion systems with the desire to teach the basic theory and applications of electron and ion optical devices and techniques and to create an awareness of the diversity of electron and ion optical uses for the scientist or engineer in a wide range of disciplines.



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